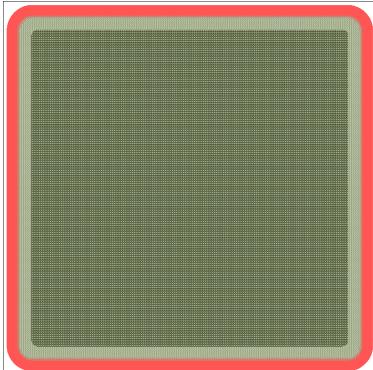


SiC Silicon-Carbide

650V 10A Schottky Diode

| Bonding Pad Information | | Chip Information | |
|-----------------------------------------------------------------------------------|--|-----------------------------|------------------------------|
|  | | Die Size (With Scribe Line) | 1,651μm x 1,651μm |
| | | Anode Pad Size | 1,101μm x 1,101μm |
| | | Scribe Line Size | 100μm |
| | | Wafer Size | 4inches |
| | | Wafer Thickness | 160μm |
| | | Gross Die | 2,402ea |
| | | Metallization | Front Side : Al/Cu : 4.0μm |
| | | | Back Side : Ti/Ni/Ag : 2.0μm |

Maximum Ratings (T_c=25°C unless otherwise noted)

| Parameter | Symbol | Value | Unit |
|--------------------------------------------------|------------------|------------|------|
| Repetitive Peak Reverse Voltage | V _{RRM} | 650 | V |
| Surge Peak Reverse Voltage | V _{RSM} | 650 | V |
| DC Current | I _F | 10 | A |
| Operating Junction and Storage Temperature Range | T _J | -55 to 175 | °C |

Electrical Characteristics (T_A=25°C unless otherwise noted)

| Parameter | Symbol | Conditions | Min. | Typ. | Max. | Unit |
|-------------------------|----------------|-----------------------------------------------------------------------------|------|------|------|------|
| DC Blocking Voltage | V _R | I _R =100uA | 650 | - | - | V |
| Forward Voltage | V _F | I _F =5A, T _J =25 °C | - | 1.2 | 1.5 | V |
| | | I _F =5A, T _J =175 °C | - | 1.4 | - | |
| | | I _F =10A, T _J =25 °C | - | 1.4 | 1.7 | |
| | | I _F =10A, T _J =175 °C | - | 1.9 | - | |
| Reverse Current | I _R | V _R =650V, T _J =25 °C | - | 1 | 50 | μA |
| | | V _R =650V, T _J =175 °C | - | 20 | 200 | |
| Total Capacitive Charge | Q _C | V _R =400V, T _J =25 °C $Q_C = \int_0^{V_R} C(V) dV$ | - | 22 | - | nC |
| Total Capacitance | C _j | V _R =400V, f=1MHz | - | 38 | - | pF |

NOTE:

- I_F evaluated by TO247-2L package type.
- The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.